

PME CAPACITORS

Extended Range For SPACE APPLICATIONS NASA SPEC S311-P-829

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WHY A NEW SPEC.?

NEED FOR:

A.LIGHTER/SMALLER CAPS (0402 min. versus 0805 min. Planning 0201 for 2014)

B.LOWER VOLTAGE

(5 V min. versus 50 V min.)

C.LOW INDUCTANCE

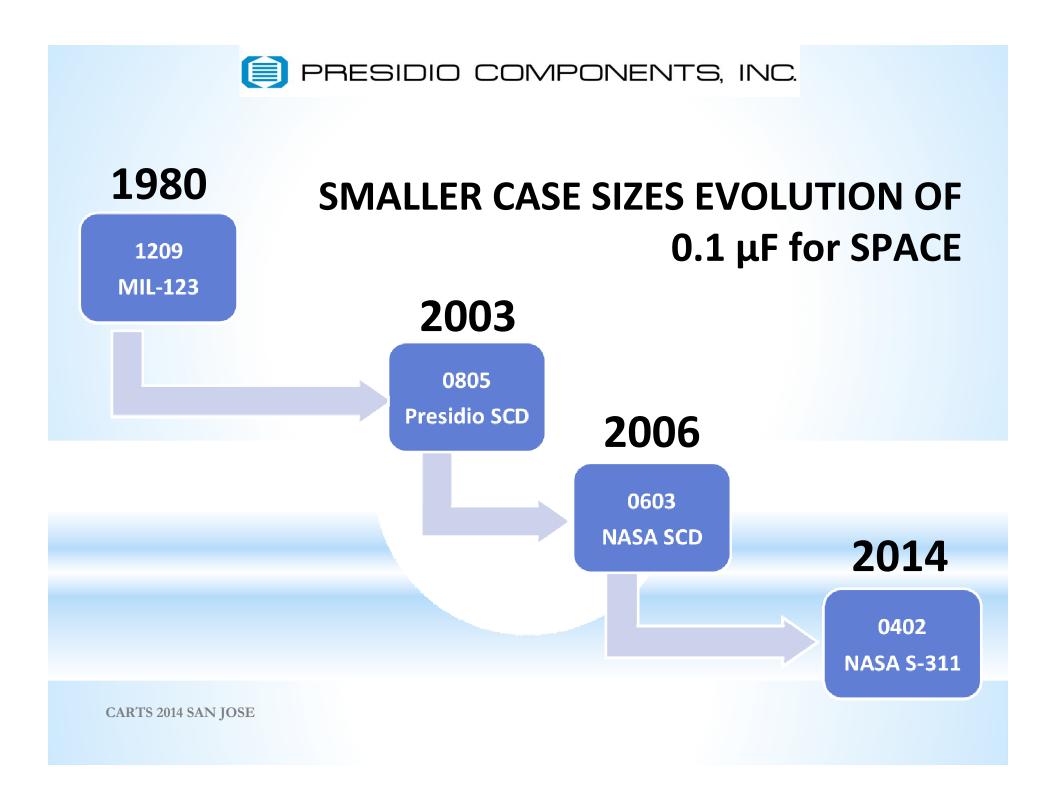
(reverse geometry)

D.MORE CAPACITANCE per case size



	0402	0403	0504	0603	0805	1206	1209	1712	1725	2225	DT
10 Volt	0.01			0.22	1	1.8	2.7	4.7			0.3
16 Volt	0.0068	0.022	0.082	0.1	0.22	0.39	0.68	1.2	3.3	3.9	0.4
25 Volt	0.0047	0.015	0.047	0.027	0.1	0.27	0.47	1	2.2	3.3	0.8
50 Volt	0.0039	0.012	0.039	0.022	0.1	0.22	0.39	0.68	1.8	2.2	0.8
100 Volt	0.0012	0.0022	0.0068	0.0033	0.022	0.1	0.15	0.27	0.68	1	1

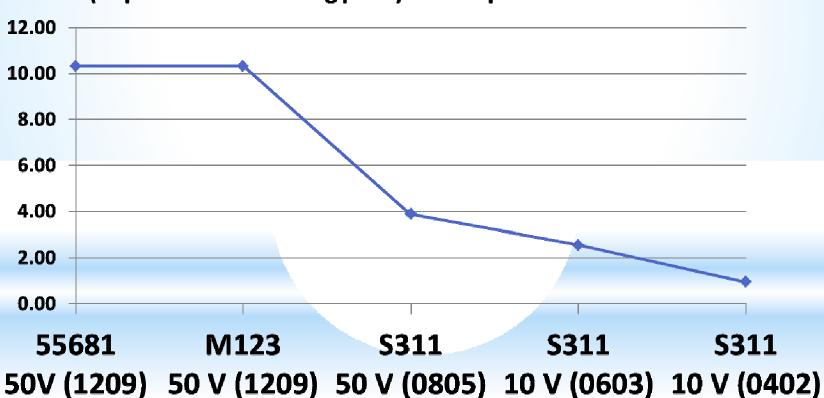
S-311-P-829 OFFERS MUCH WIDER RANGE OF PARTS THAN MIL-PRF-123





SMALLER CASE SIZES

(mm²) REDUCTION IN AREA (Capacitor + Mounting pads) for 0.1 μF



CARTS 2014 SAN JOSE



SPACE QUALIFIED PARTS

- 1) R&D on PME is active
- 2) We can go **thin** with PME Space: 7.5 μm – Commercial: 2 μm
- 3) We can test small parts (0201)
- 4) No compromise on the screening (Tougher than MIL-PRF-123)
 TOR COMPLIANT



R & D on PME is ACTIVE

- We are working with our suppliers which in many cases also supply the BME capacitor industry to improve dielectrics, grain size, metal powders, purity.
- Internally we are continuously optimizing our processes, design, tape casting, terminations, reduction of defects



MORE CAPACITANCE

DIFFERENT DIELECTRIC HIGHER K - X7R versus BX

THINNER LAYERS7.5 μm AVAILABLE FOR SPACE APPS



Dielectrics: Characteristics

	X7R	вх	NPO/BP
K (typical)	4000	2200	90
Q (typical)	60	100	1000
TC	,	. =	
(-55/+125°C)	±15%	±15%	±30
(-33/+123 C)	max.	max.	ppm/℃

	LAYERS	DT (inches)	Grains per Layer
G311P829BRX475L5N1	100	.0005	>10



LOWER VOLTAGES

- MOST CIRCUITS WORK AT VERY LOW VOLTAGES
- NO NEED FOR THE 50 V min. OF M123
- 5, 6.3, 10, 16 and 25 V AVAILABLE WITH S311



LOW INDUCTANCE CASE SIZES for HIGH FREQUENCY APPLICATIONS

NO REVERSE GEOMETRY AVAILABLE WITH M123

O306, 0508, 0612 AND 0912 HAVE BEEN ADDED TO **S**311.

We can go thin with PME (0.3 mil or 7.5 μm)

- M123 specifies 0.8 mil minimum but in practice the layers are much thicker (1.2 mils min)
- Started 10 years ago with a true 0.8 mil (0805 0.1 μF 25 V)
- Currently 0.3 mil (0805 1 μF 10V)



NO SILVER MIGRATION ISSUE WITH LOW VOLTAGE LIFE TEST

TEST PERFORMED: 0603, X7R, 0.1 uF, 5V, Tin-Lead

- ▶1.5 V
- **≥**4000 H
- > 1300 pcs
- ≥125°c
- > 0 failure

NO EVIDENCE OF SILVER MIGRATION WITH THIN LAYER PME



WE CAN TEST SMALL CASE SIZE DOWN TO 0201

THE FOLLOWING SCREENING IS ROUTINELY PERFORMED ON 0201:

- > ULTRASONIC SCANNING
- **VOLTAGE CONDITIONING**
- LIFE TEST

We are working on adding 0201 0.01µF 10V to the S311 drawing



NO COMPROMISE ON SCREENING TOUGHER TESTING than MIL-PRF-123

QUALIFICATION: more stringent than M123 (125 PC/4000 hr life test/0 Failures)

LOT TESTS:

Group A: (same as M123) PDA final 48 h Presidio counts all hard electrical failures towards final 48 hour & overall PDA

Group B Life Test Sample Size Based on Dielectric Thickness

TOR COMPLIANT



For ALL our G311 parts from 2010 to 2013

OPERATING TEMPERATURE	50℃	85℃	105℃	125℃
OPERATING	50% OF	50% OF	50% OF	RATED
VOLTAGE	RATED	RATED	RATED	
ACCELERATED	2.5	100.98	15.98	317
HOURS	TRILLION	BILLION	BILLION	MILLION
FIT/FAILURE RATE	<.0004	<.01	<.06	S LEVEL